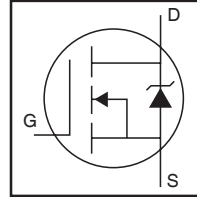


IRFB4410PbF
IRFS4410PbF
IRFSL4410PbF

Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

HEXFET® Power MOSFET



V_{DSS}		100V
R_{DS(on)}	typ.	8.0mΩ
	max.	10mΩ
I_D		88A

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free



Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	88①②	A
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	63①②	
I _{DM}	Pulsed Drain Current ②	380	
P _D @ T _C = 25°C	Maximum Power Dissipation	200③	W
	Linear Derating Factor	1.3③	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ④	19	V/ns
T _J	Operating Junction and Storage Temperature Range	-55 to + 175	°C
T _{STG}			
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

Avalanche Characteristics

E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ③	220	mJ
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 16a, 16b	A
E _{AR}	Repetitive Avalanche Energy ⑤		mJ

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R _{θJC}	Junction-to-Case ⑥	—	0.61⑦	°C/W
R _{θCS}	Case-to-Sink, Flat Greased Surface , TO-220	0.50	—	
R _{θJA}	Junction-to-Ambient, TO-220 ⑧	—	62	
R _{θJA}	Junction-to-Ambient (PCB Mount) , D²Pak ⑧ ⑨	—	40	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100	—	—	V	V _{GS} = 0V, I _D = 250μA
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	—	0.094	—	V/°C	Reference to 25°C, I _D = 1mA [Ⓜ]
R _{DS(on)}	Static Drain-to-Source On-Resistance	—	8.0	10	mΩ	V _{GS} = 10V, I _D = 58A [Ⓟ]
V _{GS(th)}	Gate Threshold Voltage	2.0	—	4.0	V	V _{DS} = V _{GS} , I _D = 150μA
I _{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	V _{DS} = 100V, V _{GS} = 0V
		—	—	250		V _{DS} = 100V, V _{GS} = 0V, T _J = 125°C
I _{GSS}	Gate-to-Source Forward Leakage	—	—	200	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage	—	—	-200		V _{GS} = -20V
R _G	Gate Input Resistance	—	1.5	—	Ω	f = 1MHz, open drain

Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
gfs	Forward Transconductance	120	—	—	S	V _{DS} = 50V, I _D = 58A
Q _g	Total Gate Charge	—	120	180	nC	I _D = 58A
Q _{gs}	Gate-to-Source Charge	—	31	—		V _{DS} = 80V
Q _{gd}	Gate-to-Drain ("Miller") Charge	—	44	—		V _{GS} = 10V [Ⓟ]
t _{d(on)}	Turn-On Delay Time	—	24	—	ns	V _{DD} = 65V
t _r	Rise Time	—	80	—		I _D = 58A
t _{d(off)}	Turn-Off Delay Time	—	55	—		R _G = 4.1Ω
t _f	Fall Time	—	50	—		V _{GS} = 10V [Ⓟ]
C _{iss}	Input Capacitance	—	5150	—	pF	V _{GS} = 0V
C _{oss}	Output Capacitance	—	360	—		V _{DS} = 50V
C _{rss}	Reverse Transfer Capacitance	—	190	—		f = 1.0MHz
C _{oss eff. (ER)}	Effective Output Capacitance (Energy Related)	—	420	—		V _{GS} = 0V, V _{DS} = 0V to 80V [Ⓣ] , See Fig.11
C _{oss eff. (TR)}	Effective Output Capacitance (Time Related) [Ⓢ]	—	500	—		V _{GS} = 0V, V _{DS} = 0V to 80V [Ⓢ] , See Fig. 5

Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)	—	—	88 [Ⓛ]	A	MOSFET symbol showing the integral reverse p-n junction diode.
I _{SM}	Pulsed Source Current (Body Diode) [Ⓜ]	—	—	380	A	
V _{SD}	Diode Forward Voltage	—	—	1.3	V	T _J = 25°C, I _S = 58A, V _{GS} = 0V [Ⓟ]
t _{rr}	Reverse Recovery Time	—	38	56	ns	T _J = 25°C V _R = 85V, T _J = 125°C I _F = 58A
Q _{rr}	Reverse Recovery Charge	—	61	92	nC	T _J = 25°C T _J = 125°C di/dt = 100A/μs [Ⓟ]
I _{RRM}	Reverse Recovery Current	—	2.8	—	A	T _J = 25°C
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

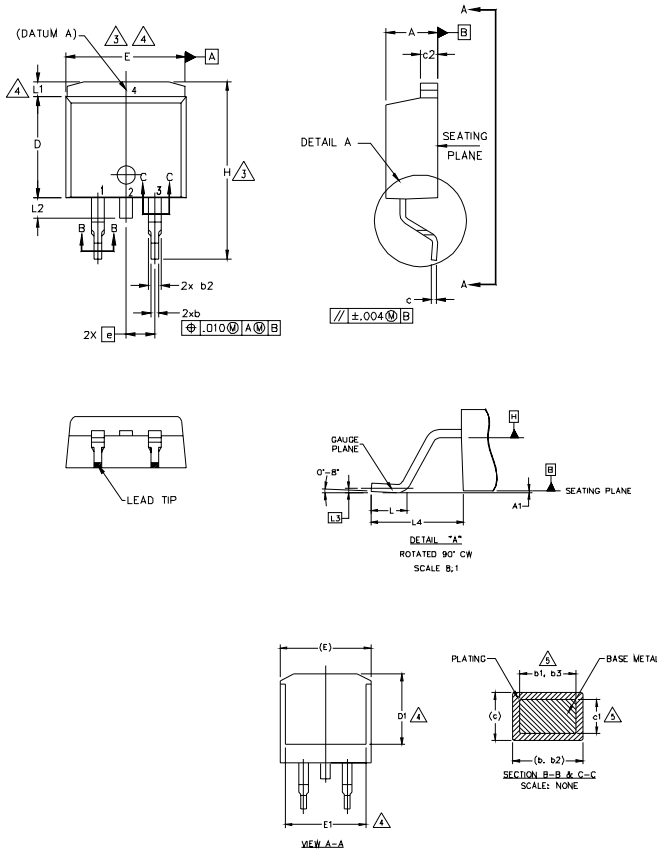
Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax}, starting T_J = 25°C, L = 0.14mH
R_G = 25Ω, I_{AS} = 58A, V_{GS} = 10V. Part not recommended for use above this value.
- ④ I_{SD} ≤ 58A, di/dt ≤ 650A/μs, V_{DD} ≤ V_{(BR)DSS}, T_J ≤ 175°C.
- ⑤ Pulse width ≤ 400μs; duty cycle ≤ 2%.
- Ⓢ C_{oss eff. (TR)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- Ⓣ C_{oss eff. (ER)} is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- Ⓛ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- Ⓟ R_θ is measured at T_J approximately 90°C.
- Ⓢ R_{θJC} (end of life) for D²Pak and TO-262 = 0.75°C/W. Note: This is the maximum measured value after 1000 temperature cycles from -55 to 150°C and is accounted for by the physical wearout of the die attach medium.

IRFB/S/SL4410PbF

D²Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
7. CONTROLLING DIMENSION: INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	4.06	4.83	.160	.190	5
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	
c	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	
D1	6.86	-	.270	-	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245	-	4
e	2.54 BSC		.100 BSC		
H	14.61	15.88	.575	.625	4
L	1.78	2.79	.070	.110	
L1	-	1.65	-	.066	
L2	1.27	1.78	-	.070	
L3	0.25 BSC		.010 BSC		
L4	4.78	5.28	.188	.208	

LEAD ASSIGNMENTS

- HEXFET**
- 1.- GATE
 - 2, 4.- DRAIN
 - 3.- SOURCE

- IGBTs, CoPACK**
- 1.- GATE
 - 2, 4.- COLLECTOR
 - 3.- EMITTER

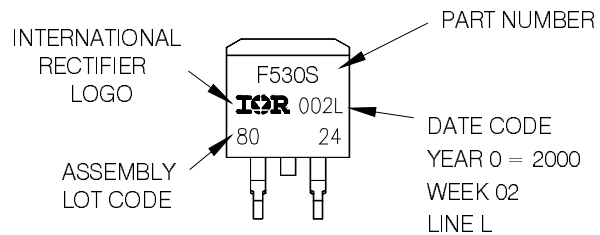
- DIODES**
- 1.- ANODE *
 - 2, 4.- CATHODE
 - 3.- ANODE

* PART DEPENDENT.

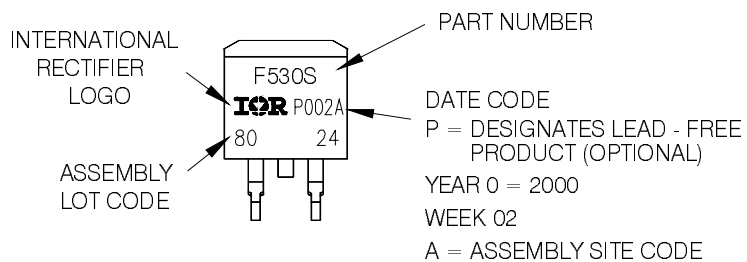
D²Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE "L"

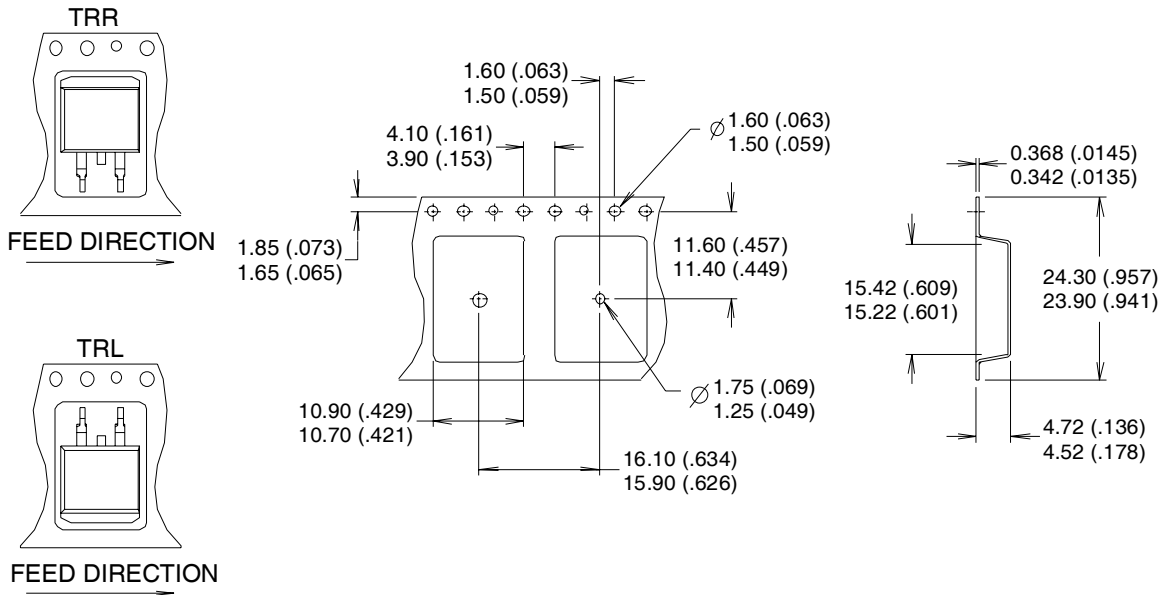
Note: "P" in assembly line position
indicates "Lead - Free"



OR

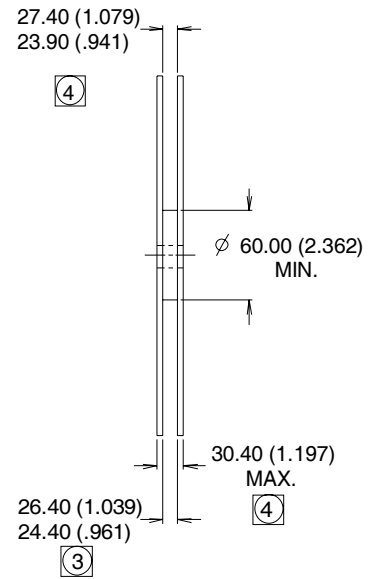


D²Pak (TO-263AB) Tape & Reel Information



NOTES :

1. CONFORMS TO EIA-418.
2. CONTROLLING DIMENSION: MILLIMETER.
- ③ DIMENSION MEASURED @ HUB.
- ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.



Data and specifications subject to change without notice.
This product has been designed and qualified for the Industrial market.